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INTEGRATED CIRCUITS



Product specification

1991 Feb 14

IC15 Data Handbook





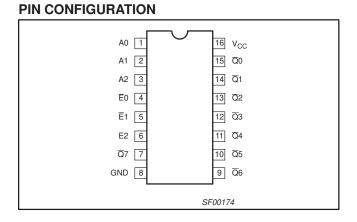
74F138

FEATURE

- Demultiplexing capability
- Multiple input enable for easy expansion
- Ideal for memory chip select decoding
- Industrial temperature range available (-40°C to +85°C)

DESCRIPTION

The 74F138 decoder accepts three binary weighted inputs (A0, A1, A2) and when enabled, provides eight mutually exclusive, active low outputs ($\overline{Q}0 - \overline{Q}7$). The device features three enable inputs; two active low (E0, E1) and one active high (E2). Every output will be high unless E0 and E1 are low and E2 is high. This multiple enable function allows easy parallel expansion of the device to 1-of-32 (5 lines to 32 lines) decoder with just four 74F138s and one inverter (see Figure 1). The device can be used as an eight output demultiplexer by using one of the active low enable inputs as the data input and the remaining enable inputs as strobes. Enable inputs not used must be permanently tied to their appropriate active high or active low state.



ТҮРЕ	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F138	5.8ns	13mA

ORDERING INFORMATION

	ORDE	ER CODE	
DESCRIPTION	COMMERCIAL RANGE V _{CC} = 5V ±10%, T _{amb} = 0°C to +70°C	INDUSTRIAL RANGE V_{CC} = 5V ±10%, T _{amb} = -40°C to +85°C	PKG DWG #
16-pin plastic DIP	N74F138N	I74F138N	SOT38-4
16-pin plastic SO	N74F138D	I74F138D	SOT109-1

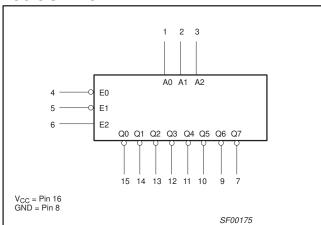
INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
A0 – A2	Address inputs	1.0/1.0	20µA/0.6mA
Ē0, Ē1	Enable inputs (active Low)	1.0/1.0	20µA/0.6mA
E2	Enable input (active High)	1.0/1.0	20µA/0.6mA
$\overline{Q}0 - \overline{Q}7$	Data outputs	50/33	1.0mA/20mA

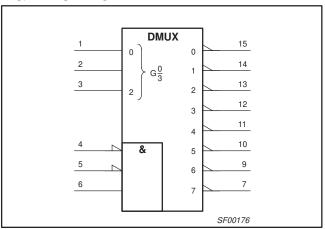
NOTE:

One (1.0) FAST unit load is defined as: 20µA in the High state and 0.6mA in the Low state.

LOGIC SYMBOL

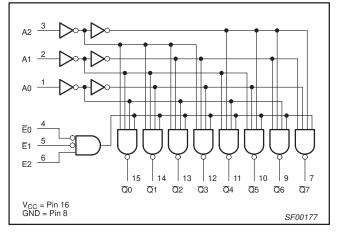


IEC/IEEE SYMBOL



74F138

LOGIC DIAGRAM



FUNCTION TABLE

		INP	UTS						OUT	PUTS			
Ē0	Ē1	E2	A0	A1	A2	<u>Q</u> 0	Q 1	Q2	Q 3	<u>Q</u> 4	Q 5	<u>Q</u> 6	Q7
Н	Х	Х	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
Х	Н	Х	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
Х	Х	L	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
L	L	Н	L	L	L	L	Н	Н	Н	Н	Н	Н	Н
L	L	Н	Н	L	L	Н	L	Н	Н	Н	Н	Н	Н
L	L	Н	L	Н	L	Н	Н	L	Н	Н	Н	Н	Н
L	L	Н	Н	Н	L	Н	Н	Н	L	Н	Н	Н	Н
L	L	Н	L	L	Н	Н	Н	Н	Н	L	Н	Н	Н
L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Н
L	L	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	L	Н
L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L

NOTES:

H = High voltage level

Low voltage level L = Х =

Don't care

APPLICATION

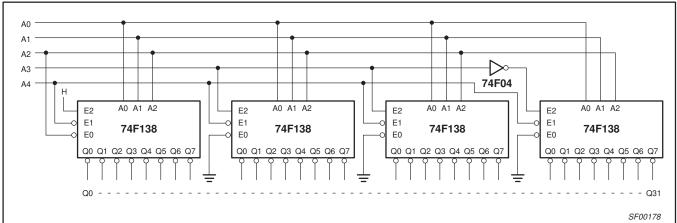


Figure 1. Expansion of 1-of-8 Decoding

74F138

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device.

Unless otherwise noted these limits are over the operating free air temperature range.)

SYMBOL	PARAMETER		RATING	UNIT
V _{CC}	Supply voltage		-0.5 to +7.0	V
V _{IN}	Input voltage		-0.5 to +7.0	V
I _{IN}	Input current		-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state		-0.5 to V _{CC}	V
I _{OUT}	Current applied to output in Low output state	-	40	mA
-		Commercial range	0 to +70	°C
T _{amb}	Operating free-air temperature range	Industrial range	-40 to +85	°C
T _{stg}	Storage temperature range	-	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

OVMDO	DADAMETED	PARAMETER					
SYMBOL	PARAMETER		MIN	NOM	MAX	UNIT	
V _{CC}	Supply voltage	4.5	5.0	5.5	V		
V _{IH}	High-level input voltage		2.0			V	
V _{IL}	Low-level input voltage			0.8	V		
I _{IK}	Input clamp current				-18	mA	
I _{OH}	High-level output current				-1	mA	
I _{OL}	Low-level output current				20	mA	
T _{amb}	Operating free-air temperature range	Commercial range	0		+70	°C	
amb	Operating nee-an temperature range	Industrial range	-40		+85	°C	

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

OVMDOL	DADAMETED	TEST CO		LIMITS		UNIT		
SYMBOL	PARAMETER	TEST COI	MIN	TYP ²	MAX			
V	Llich loud output voltogo	$V_{CC} = MIN, V_{IL} = MAX,$		$\pm 10\% V_{CC}$	2.5			V
V _{OH}	High-level output voltage	V _{IH} = MIN	I _{OH} = MAX	±5%V _{CC}	2.7	3.4		V
M		$V_{CC} = MIN, V_{IL} = MAX, V_{IH} = MIN$		±10%V _{CC}		0.30	0.50	V
V _{OL}	Low-level output voltage	V _{IH} = MIN	I _{OL} = MAX	±5%V _{CC}		0.30	0.50	V
V _{IK}	Input clamp voltage	$V_{CC} = MIN, I_I = I_{IK}$				-0.73	-1.2	V
lı	Input current at maximum input voltage	$V_{CC} = MAX, V_I = 7.0V$					100	μA
I _{IH}	High-level input current	$V_{CC} = MAX, V_I = 2.7V$					20	μA
IIL	Low-level input current	$V_{CC} = MAX, V_I = 0.5V$					-0.6	mA
I _{OS}	Short-circuit output current ³	V _{CC} = MAX			-60		-150	mA
I _{CC}	Supply current ⁴ (total)	$V_{CC} = MAX$				13	20	mA

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$. 3. Not more than one output should be shorted at a time. For testing I_{OS} , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

4. Measure I_{CC} , outputs must be open, V_{IN} on all inputs = 4.5V.

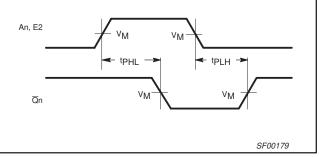
74F138

AC ELECTRICAL CHARACTERISTICS

						LI	MITS			
SYMBOL	PARAMETER	TEST CONDITION	T _{an} C	_C = +5. _{nb} = +2 _L = 50p _L = 500	5°C ⊳F	T _{amb} = 0°C	0V ± 10% C to +70°C 50pF 500Ω			UNIT
			MIN	ТҮР	MAX	MIN	MAX	MIN	MAX	
t _{PLH} t _{PHL}	Propagation delay An to Qn	Waveform 1, 2	3.5 4.0	5.6 6.1	7.0 8.0	3.5 4.0	8.0 9.0	3.0 3.5	8.5 9.0	ns
t _{PLH} t _{PHL}	Propagation delay $\overline{E0}$ or $\overline{E1}$ to \overline{Qn}	Waveform 2	3.5 3.0	6.4 5.3	7.0 7.0	3.5 3.0	8.0 7.5	3.0 3.0	8.0 7.5	ns
t _{PLH} t _{PHL}	Propagation delay E2 to Qn	Waveform 1	4.0 3.5	6.2 5.6	8.0 7.5	4.0 3.5	9.0 8.5	4.0 3.5	9.5 8.5	ns

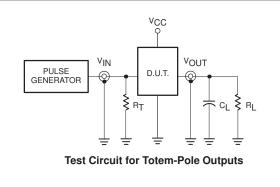
AC WAVEFORMS

For all waveforms, $V_M = 1.5V$



Waveform 1. Propagation Delay for Inverting Outputs

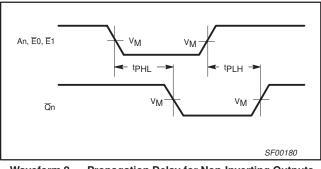
TEST CIRCUIT AND WAVEFORMS



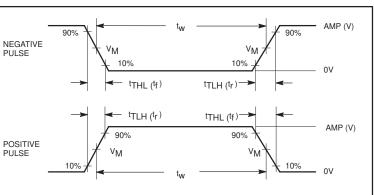
DEFINITIONS:

- R_L = Load resistor;
- see AC ELECTRICAL CHARACTERISTICS for value.

 CL
 Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.
- $R_T = \mbox{Termination resistance should be equal to } Z_{OUT} \mbox{ of } pulse \mbox{ generators.} \label{eq:RT}$

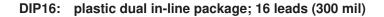


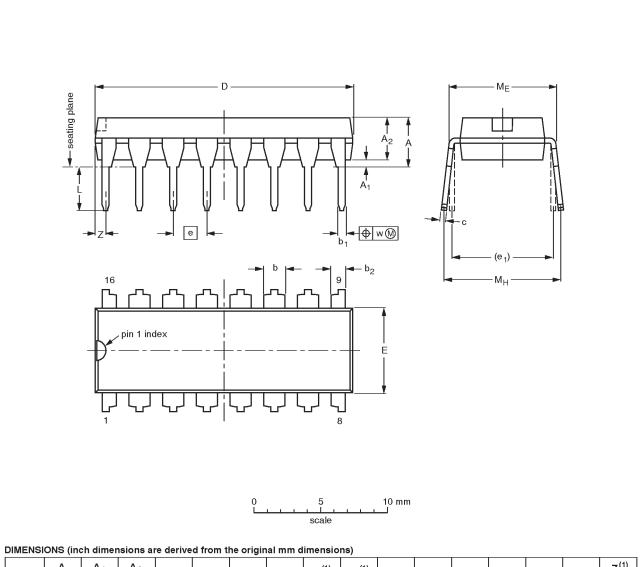
Waveform 2. Propagation Delay for Non-Inverting Outputs



Input Pulse Definition

fomily	INPUT PULSE REQUIREMENTS									
family	amplitude	VM	rep. rate	tw	t _{TLH}	t _{THL}				
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns				





UNIT	A max.	A ₁ min.	A ₂ max.	ь	b ₁	b ₂	c	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	ME	мн	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.030

Note

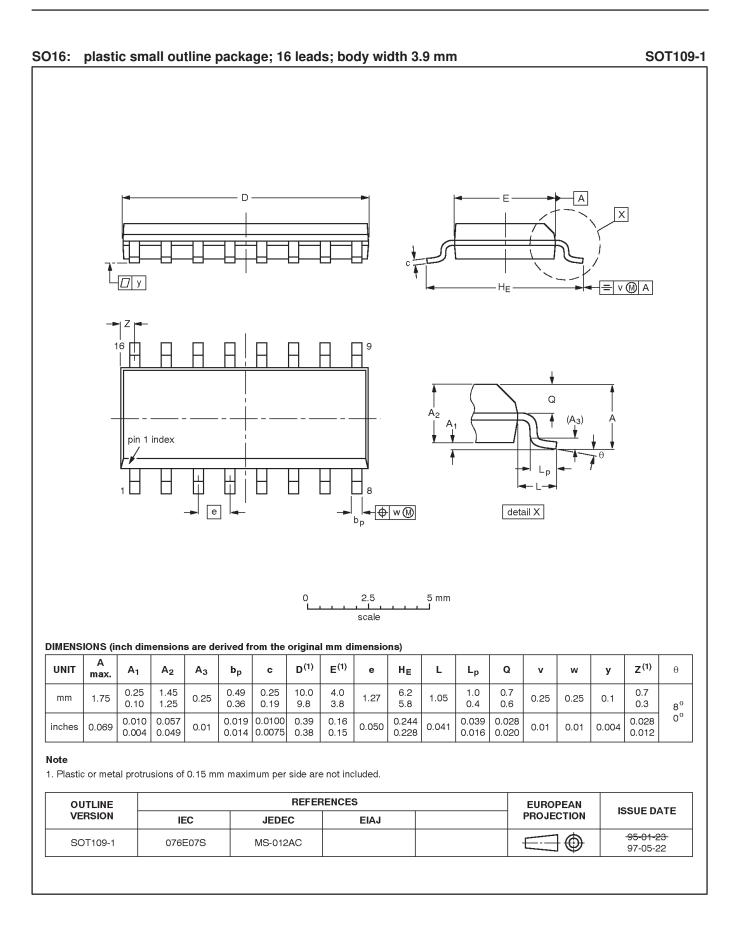
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFERENCES EUROPE				ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT38-4						-92-11-17 95-01-14

74F138

SOT38-4

74F138



74F138

Data sheet status

Data sheet status	Product status	Definition ^[1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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